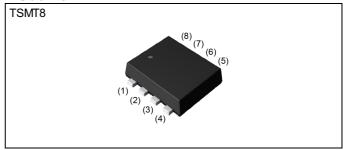
-12V Pch+Pch Middle Power MOSFET

V _{DSS}	-12V
R _{DS(on)} (Max.)	22mΩ
I _D	±5.5A
P _D	1.5W

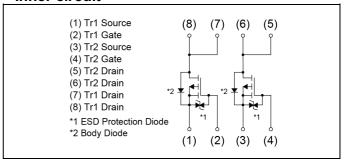
Features

- 1) Low on resistance.
- 2) Small Surface Mount Package .
- 3) Pb-free lead plating; RoHS compliant.
- 4) Halogen Free.

Outline



●Inner circuit



Packaging specifications

	Packing	Embossed Tape					
	Reel size (mm)	180					
Туре	Tape width (mm)	8					
	Basic ordering unit (pcs)	3000					
	Taping code	TR					
	Marking	J13					

Application

Switching

● Absolute maximum ratings (T_a = 25°C) < It is the same ratings for the Tr1 and Tr2>

Parameter	Symbol	Value	Unit		
Drain - Source voltage	V_{DSS}	-12	V		
Continuous drain current	I _D *1	±5.5	Α		
Pulsed drain current	I _{D,pulse} *2	±18	Α		
Gate - Source voltage	V _{GSS}	0~-8	V		
Daylor disaination	total	D *3	1.5	W	
Power dissipation	element	- P _D *3	1.25		
Junction temperature	T _j	150	°C		
Range of storage temperature	T _{stg}	-55 to +150	°C		

●Thermal resistance

Parameter		Cymah al	Values			I India
		Symbol	Min.	Тур.	Max.	Unit
Thermal registance in patient ambient	total	D *3	-	83.3	-	°C/W
Thermal resistance, junction - ambient	element	R _{thJA} *3	1	100	-	C/VV

● Electrical characteristics (T_a = 25°C) < It is the same characteristics for the Tr1 and Tr2>

	0 1 1	O Pr		Values			
Parameter	Symbol Conditions		Min.	Тур.	Max.	Unit	
Drain - Source breakdown voltage	V _{(BR)DSS}	$V_{GS} = 0V$, $I_D = -1mA$	-12	-	-	V	
Breakdown voltage temperature coefficient	$\frac{\Delta V_{(BR)DSS}}{\Delta T_{j}}$	I _D = -1mA referenced to 25°C	-	-5.0	-	mV/°C	
Zero gate voltage drain current	I _{DSS}	V _{DS} = -12V, V _{GS} = 0V	-	-	-10	μA	
Gate - Source leakage current	I _{GSS}	V _{DS} = 0V, V _{GS} = -8V	-	-	-10	μA	
Gate threshold voltage	V _{GS(th)}	$V_{DS} = -6V, I_{D} = -1mA$	-0.3	-	-1.0	V	
Gate threshold voltage temperature coefficient	$\frac{\DeltaV_{\text{GS(th)}}}{\DeltaT_j}$	I _D = -1mA referenced to 25°C	-	2.7	-	V/°C	
		V_{GS} = -4.5V, I_D = -5.5A	1	15	22		
Static drain - source	D *4	V_{GS} = -2.5V, I_D = -2.7A	-	19	28	O	
on - state resistance	R _{DS(on)} *4	$V_{GS} = -1.8V, I_D = -2.7A$	1	24	38	mΩ	
		V _{GS} = -1.5V, I _D = -1.1A	-	29	58		
Transconductance	9 _{fs} *4	$V_{DS} = -6V, I_{D} = -5.5A$	8.5	-	-	S	

^{*1} Limited only by maximum temperature allowed.

^{*2} Pw ≤ 10µs, Duty cycle ≤ 1%

^{*3} Mounted on a ceramic board.

^{*4} Pulsed

ullet Electrical characteristics (T_a = 25°C) <It is the same characteristics for the Tr1 and Tr2>

Parameter	Cumb of	Conditions		Unit		
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Offic
Input capacitance	C _{iss}	V _{GS} = 0V	-	6300	-	
Output capacitance	C _{oss}	V _{DS} = -6V	-	750	-	pF
Reverse transfer capacitance	C _{rss}	f = 1MHz	-	750	-	
Turn - on delay time	t _{d(on)} *4	$V_{DD} \simeq -6V, V_{GS} = -4.5V$	-	13	-	
Rise time	t _r *4	I _D = -2.7A	-	100	-	-
Turn - off delay time	t _{d(off)} *4	$R_L = 2.2\Omega$	-	400	-	ns
Fall time	t _f *4	$R_G = 10\Omega$	-	200	-	

● Gate charge characteristics (T_a = 25°C) < It is the same characteristics for the Tr1 and Tr2>

Parameter	Symbol	Conditions	Values			Unit
raianetei	Symbol		Min.	Тур.	Max.	Offit
Total gate charge	Q _g *4		-	60	-	
Gate - Source charge	Q _{gs} *4	$V_{DD} \simeq -6V, I_{D} = -5.5A$ $V_{GS} = -4.5V$	-	10	-	nC
Gate - Drain charge	Q _{gd} *4	v GS = -4.5 v	-	9	-	

● Body diode electrical characteristics (Source-Drain) (T_a = 25°C)

<It is the same characteristics for the Tr1 and Tr2>

Parameter	Symbol	Conditions	Values			Unit	
- Farameter	Symbol	ool Conditions -	Min.	Тур.	Max.	Unit	
Body diode continuous forward current	I _S *1	T _a = 25°C	-	-	-1	^	
Body diode pulse current	l _{SP} *2		-	-	-18	Α	
Forward voltage	V _{SD} *4	$V_{GS} = 0V, I_S = -5.5A$	-	-	-1.2	V	

Fig.1 Power Dissipation Derating Curve

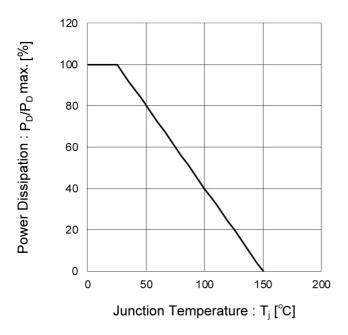
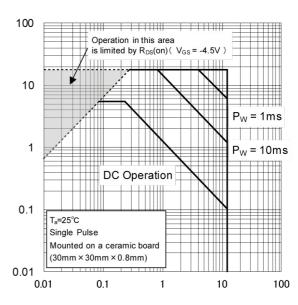


Fig.2 Maximum Safe Operating Area



Drain Current: -l_D [A]

Drain - Source Voltage : $-V_{DS}[V]$

Fig.3 Normalized Transient Thermal Resistance vs. Pulse Width

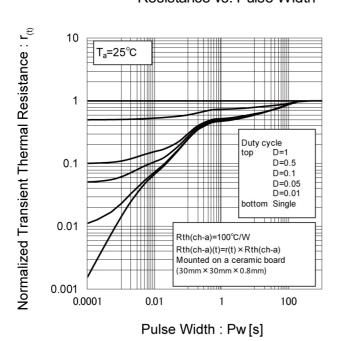
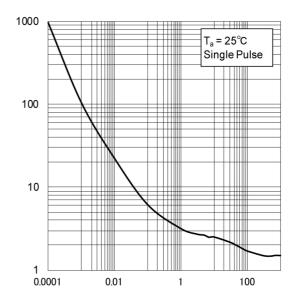


Fig.4 Single Pulse Maximum Power dissipation



Pulse Width: Pw[s]

Peak Transient Power: P(W)

Drain Current : -I_D [A]

• Electrical characteristic curves

Fig.5 Typical Output Characteristics(I)

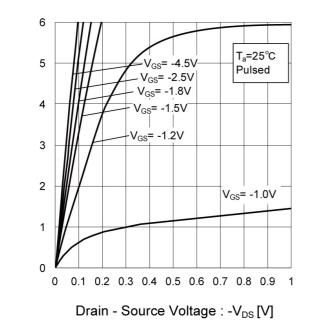


Fig.6 Typical Output Characteristics(II)

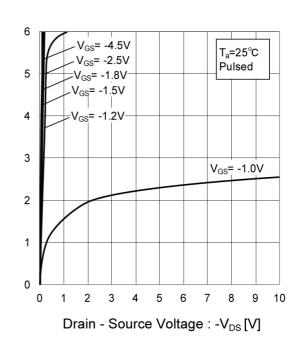
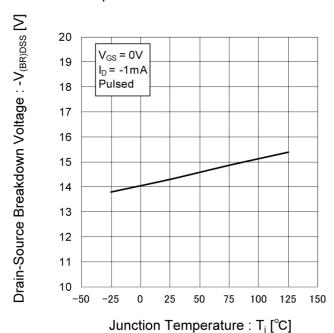


Fig.7 Breakdown Voltage vs. Junction Temperature



ROHM

Drain Current : -I_D [A]

Fig.8 Typical Transfer Characteristics

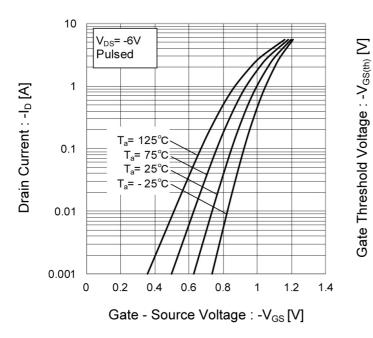


Fig.9 Gate Threshold Voltage vs. Junction Temperature

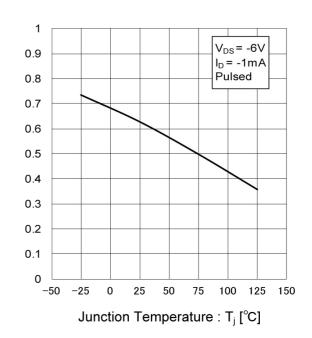


Fig.10 Tranceconductance vs. Drain Current

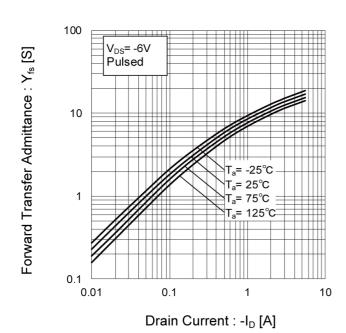


Fig.11 Drain Current Derating Curve

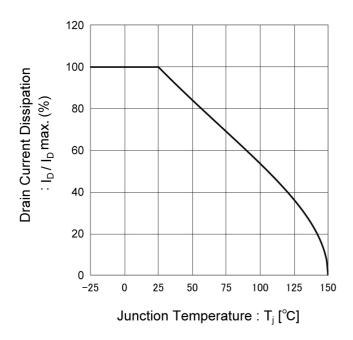


Fig.12 Static Drain - Source On - State Resistance vs. Gate Source Voltage

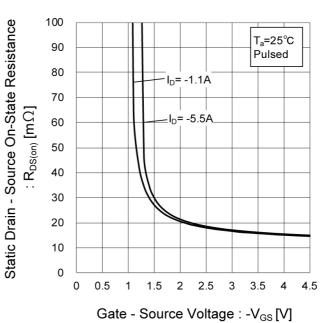


Fig.13 Static Drain - Source On - State Resistance vs. Junction Temperature

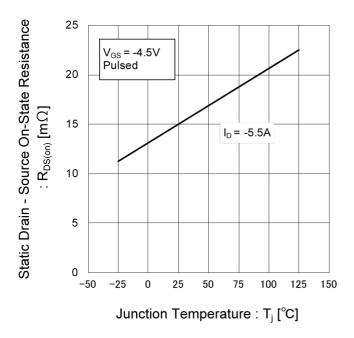


Fig.14 Static Drain - Source On - State Resistance vs. Drain Current(I)

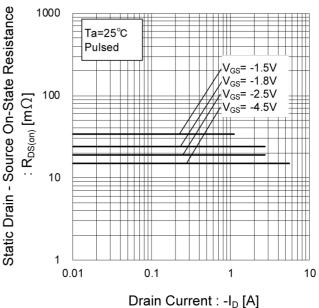


Fig.15 Static Drain - Source On - State Resistance vs. Drain Current(II)

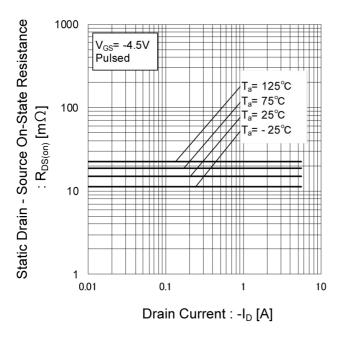


Fig.16 Static Drain - Source On - State Resistance vs. Drain Current(III)

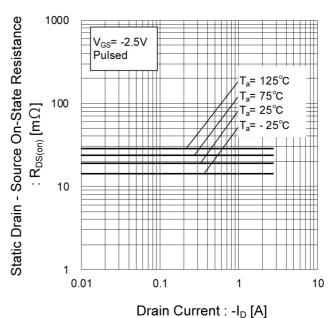


Fig.17 Static Drain - Source On - State Resistance vs. Drain Current(IV)

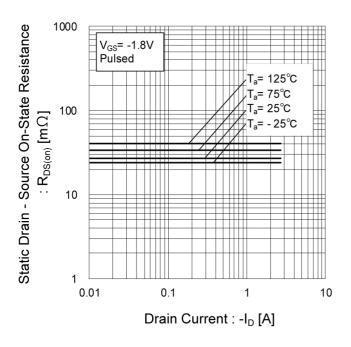


Fig.18 Static Drain - Source On - State Resistance vs. Drain Current(V)

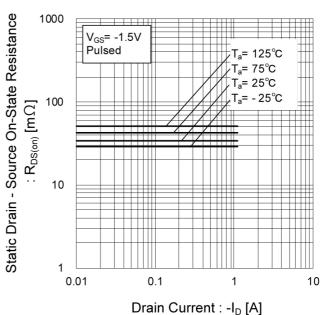


Fig.19 Typical Capacitance vs. Drain - Source Voltage

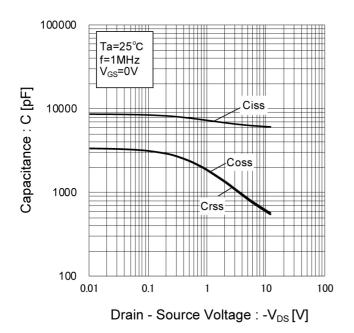


Fig.20 Switching Characteristics

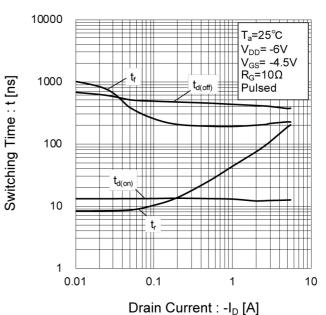


Fig.21 Dynamic Input Characteristics

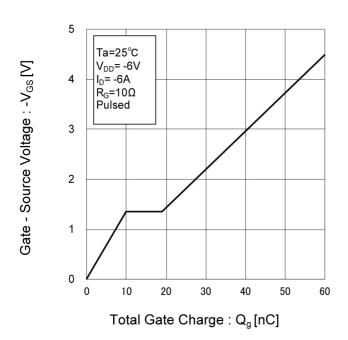
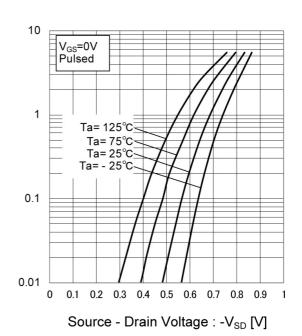


Fig.22 Source Current vs. Source Drain Voltage



Source Current : -I_s [A]

Measurement circuits

Fig.1-1 Switching Time Measurement Circuit

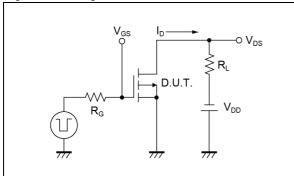


Fig.2-1 Gate Charge Measurement Circuit

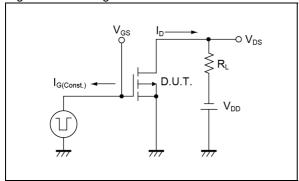


Fig.1-2 Switching Waveforms

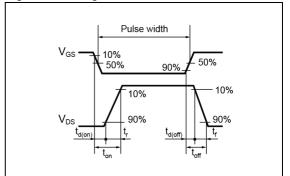
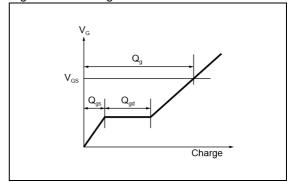
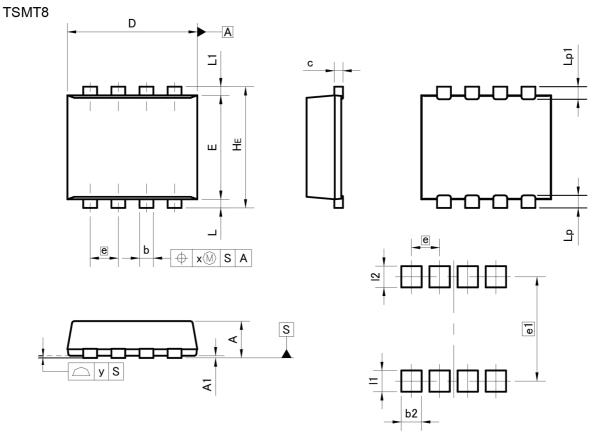


Fig.2-2 Gate Charge Waveform



Dimensions



Pattern of terminal position areas [Not a recommended pattern of soldering pads]

DIM	MILIM	ETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
Α	0.75	0.85	0.030	0.033
A1	0.00	0.05	0.000	0.002
b	0.27	0.37	0.011	0.015
С	0.12	0.22	0.005	0.009
D	2.90	3.10	0.114	0.122
E	2.30	2.50	0.091	0.098
е	0.	65	0.0	26
HE	2.70	2.90	0.106	0.114
L	0.10	0.30	0.004	0.012
L1	0.10	0.30	0.004	0.012
Lp	0.19	0.39	0.007	0.015
Lp1	0.19	0.39	0.007	0.015
х	_	0.10	_	0.004
у	_	0.10	_	0.004

	DIM	MILIM	ETERS	INC	HES
		MIN	MAX	MIN	MAX
	b2	ı	0.47	ı	0.019
	e1	2.	41	0.0	95
	11	1	0.49	ı	0.019
	12	_	0.49	_	0.019

Dimension in mm/inches



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